VDSS

600V



N Channel MOSFET (Deep Trench Superjunction)



RDS (ON) (Typ.)

 0.84Ω

Lead Free Package and Finish

Applications:

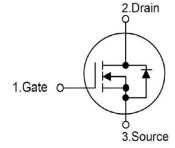
- •Adapter & Charger
- •SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

2 3	T0-220F

Not to Scale

ID

4.0A



Features:

- •Low On Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •Proprietary New Super Junction Technology
- •RoHS Compliant

Ordering Information

Part Number	Package	Marking		
RSU4N60F	T0-220F	RSU4N60F		

Absolute Maximun Ratings Tc=25℃ unless otherwise specified

Symbol	Parameter	RSU4N60F	Units
VDSS	Drain-to-Source Voltage (Note*1)	600	V
ID	Continuous Drain Current	4.0	Δ
IDM	Pulsed Drain Current (Note*2)	12.0	A
PD	Power Dissipation	32	W
VGS	Gate-to-Source Voltage	± 30	V
EAS	Single Pulse Avalanche Engergy L=10mH VDD=50V TJ=25℃	20	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	${\mathbb C}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*}Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RSU4N60F	Units	Test Conditions
Rejc	Junction-to-Case	3. 9		Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150℃.
Rө ja	Junction-to-Ambient	100		1 cubic foot chamber, free air.



OFF Characteristics $TJ=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVdss	Drain-to-source Breakdown Voltage	600		1	٧	V _{GS} =0V, I _D =250μA
IDSS	Drain-to-Source Leakage Current			1.0	μA	VDS=600V, VGS=0V
т	Gate-to-Source Forward Leakage			100	Δ.	VGS=+30V VDS=0V
Igss	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS}=-30V$ $V_{DS}=0V$

ON Characteristics $TJ=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Rds (on)	Static Drain-to-Source On-Resistance		0.84	0. 90	Ω	Vgs=10V, Id=2A
VGS (TH)	Gate Threshold Voltage	2.0		4. 0	V	Vgs=Vds, Id=250μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		8.0	1	nS	V _{DS} =480V I _D =4. 0A R _G =25 Ω
trise	Rise Time		6.0	1		
td(OFF)	Turn-OFF Delay Time		35	1		
tfall	Fall Time		20			(Note:3,4)

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		350			V _{GS} =0V
Coss	Output Capacitance		40		рF	$V_{DS}=50V$
Crss	Reverse Transfer Capacitance		4			f=1.0MHz
Qg	Total Gate Charge		7			$V_{DS}=480V$
Q_{gs}	Gate-to-Source Charge		1.5		nC	In=4.0A VGS=10V (Note:3,4)
Q_{gd}	Gate-to-Drain("Miller") Charge		2.5			



Source-Drain Diode Characteristics

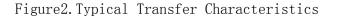
Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Is	Continuous Source Current		-	4. 0	A	Integral pn-diode
Ism	Maximum Pulsed Current			12.0	A	in MOSFET
Vsd	Diode Forward Voltage		0.9	1.2	V	Is=4.0A, VGS=0V
trr	Reverse Recovery Time		200		nS	$V_{GS}=0V$ $V_{R}=480V$
Q_{rr}	Reverse Recovery Charge		0.8		μС	Is=4.0A, di/dt=100A/μs

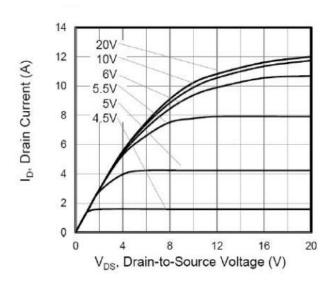
Notes:

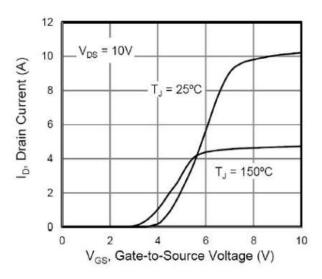
- *1. $TJ=\pm 25^{\circ}C$ to $+150^{\circ}C$.
- *2. Repetitive rating; pulse width limited by maximum junction temperature.
- *3. Pulse width≤380µs; duty cycle ≤2%.
- *4. Basically not affected by temperature.

Typical Feature curve

Figure 1. Typical Output Characteristics

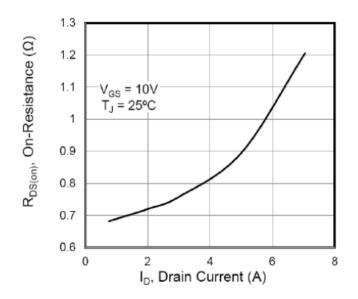








Figuer3. Typical ON Resistance vs Drain Current



Figuer4. Typical Body Diode Transfer Characteristics

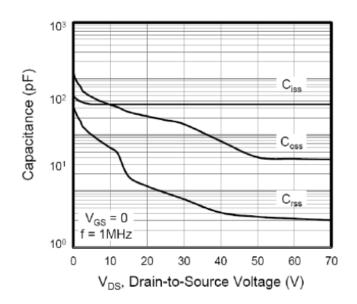


Figure 5. Body Diode Forward Voltage

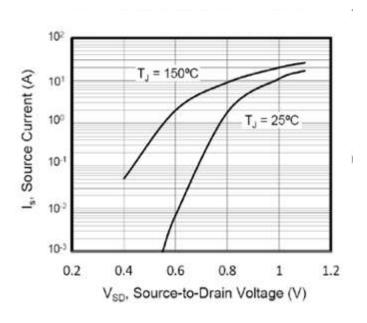


Figure 6. Typical Gate Charge vs Gate-to-Source Voltage

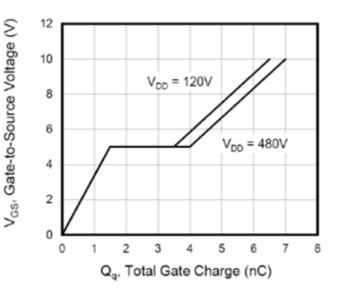


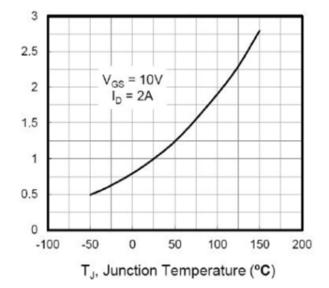


Figure 7. Threshold Voltage vs Junation Temperature

0.6 0.4 V_{GS(th)}, (Variance) 0.2 0 $I_D = 250 \mu A$ -0.2 -0.4 -0.6 -0.8 -1 -1.2 -100 -50 0 50 100 150 200

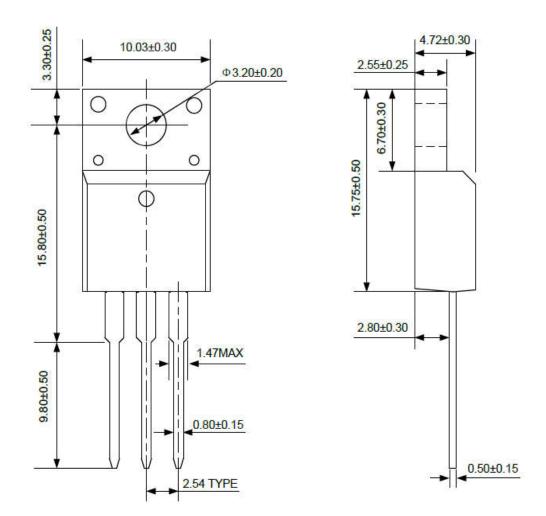
 T_J , Junction Temperature (°C)

Figure 8. Typical Drain-to-Source ON Resistance vs Junction Temperature





Package outline drawing



T0-220F



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 - b. support or sustain life,
 - c. whose failure to when properly used in accordance with instructions for used provided in the laeling, can be reasonably expected to result in significant injury to the user.
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